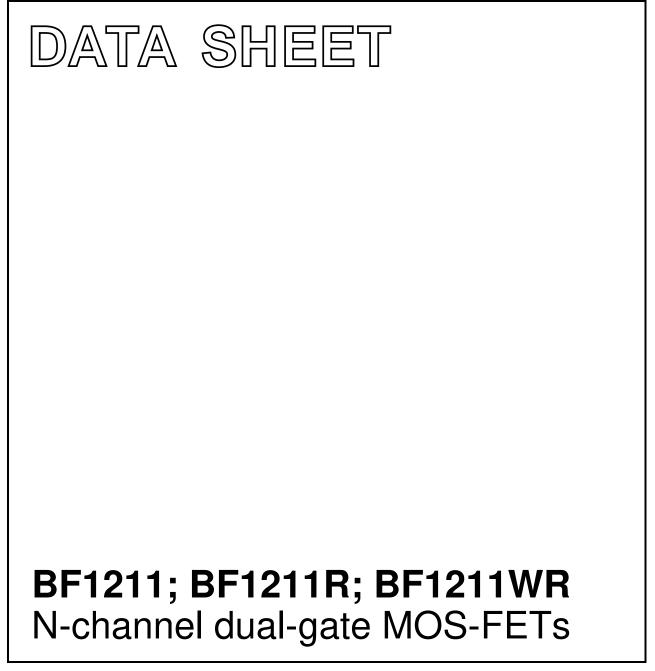
DISCRETE SEMICONDUCTORS



Product specification

2003 Dec 16



FEATURES

- Short channel transistor with high forward transfer admittance to input capacitance ratio
- · Low noise gain controlled amplifier
- · Excellent low frequency noise performance
- Partly internal self-biasing circuit to ensure good cross-modulation performance during AGC and good DC stabilization.

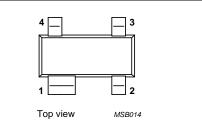
APPLICATIONS

• Gain controlled low noise VHF and UHF amplifiers for 5 V digital and analog television tuner applications.

DESCRIPTION

Enhancement type N-channel field-effect transistor with source and substrate interconnected. Integrated diodes between gates and source protect against excessive input voltage surges. The BF1211, BF1211R and BF1211WR are encapsulated in the SOT143B, SOT143R and SOT343R plastic packages respectively.

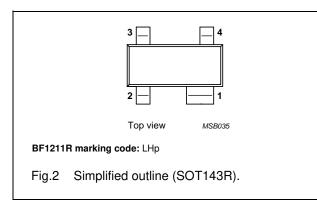
PIN	DESCRIPTION			
1	source			
2	drain			
3	gate 2			
4	gate 1			

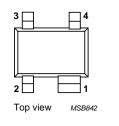


BF1211 marking code: LFp

PINNING

Fig.1 Simplified outline (SOT143B).





BF1211WR marking code: MK

Fig.3 Simplified outline (SOT343R).

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{DS}	drain-source voltage		_	-	6	V
I _D	drain current		-	-	30	mA
P _{tot}	total power dissipation		-	-	180	mW
y _{fs}	forward transfer admittance		25	30	40	mS
C _{ig1-ss}	input capacitance at gate 1		-	2.1	2.6	pF
C _{rss}	reverse transfer capacitance	f = 1 MHz	-	15	30	fF
F	noise figure	f = 400 MHz	_	0.9	1.6	dB
X _{mod}	cross-modulation	input level for k = 1% at 40 dB AGC	100	105	-	dBμV
Tj	junction temperature		-	_	150	°C

BF1211; BF1211R; BF1211WR

BF1211; BF1211R; BF1211WR

CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling.

ORDERING INFORMATION

	PACKAGE			
ITPE NUMBER	NAME DESCRIPTION		VERSION	
BF1211	_	plastic surface mounted package; 4 leads	SOT143B	
BF1211R	_	plastic surface mounted package; reverse pinning; 4 leads	SOT143R	
BF1211WR	-	plastic surface mounted package; reverse pinning; 4 leads	SOT343R	

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		-	6	V
I _D	drain current (DC)		-	30	mA
I _{G1}	gate 1 current		-	±10	mA
I _{G2}	gate 2 current		-	±10	mA
P _{tot}	total power dissipation				
	BF1211; BF1211R	$T_s \le 116 \text{ °C}$; note 1	-	180	mW
	BF1211WR	$T_s \le 122 \text{ °C}$; note 1	-	180	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-	150	°C

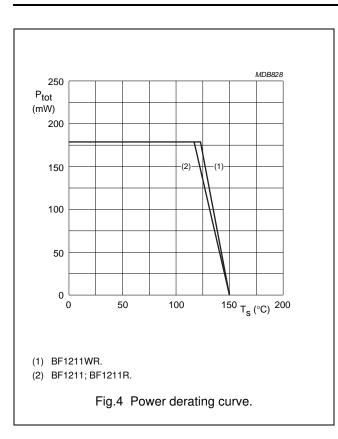
Note

1. T_s is the temperature of the soldering point of the source lead.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
R _{th(j-s)}	thermal resistance from junction to soldering point		
	BF1211; BF1211R	185	K/W
	BF1211WR	155	K/W

BF1211; BF1211R; BF1211WR



STATIC CHARACTERISTICS

$T_j = 25 \ ^\circ C$ unless otherwise s	specified.
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SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{(BR)DSS}	drain-source breakdown voltage	$V_{G1-S} = V_{G2-S} = 0$ V; $I_D = 10 \ \mu A$	6	-	V
V _{(BR)G1-SS}	gate 1-source breakdown voltage	$V_{G2-S} = V_{DS} = 0 V; I_{G1-S} = 10 mA$	6	10	V
V _{(BR)G2-SS}	gate 2-source breakdown voltage	$V_{G1-S} = V_{DS} = 0 V; I_{G2-S} = 10 mA$	6	10	V
V _{(F)S-G1}	forward source-gate 1 voltage	$V_{G2-S} = V_{DS} = 0 V; I_{S-G1} = 10 mA$	0.5	1.5	V
V _{(F)S-G2}	forward source-gate 2 voltage	$V_{G1-S} = V_{DS} = 0 V; I_{S-G2} = 10 mA$	0.5	1.5	V
V _{G1-S(th)}	gate 1-source threshold voltage	$V_{G2-S} = 4 V; V_{DS} = 5 V; I_D = 100 \ \mu A$	0.3	1	V
V _{G2-S(th)}	gate 2-source threshold voltage	$V_{G1-S} = 5 V; V_{DS} = 5 V; I_D = 100 \ \mu A$	0.35	1	V
I _{DSX}	drain-source current	$V_{G2\text{-}S}$ = 4 V; V_{DS} = 5 V; R_{G1} = 75 kΩ; note 1	11	19	mA
I _{G1-S}	gate 1 cut-off current	$V_{G2-S} = V_{DS} = 0 V; V_{G1-S} = 5 V$	-	50	nA
I _{G2-S}	gate 2 cut-off current	$V_{G1-S} = V_{DS} = 0 V; V_{G2-S} = 4 V$	_	20	nA

Note

1. R_{G1} connects G_1 to $V_{GG} = 5$ V.

BF1211; BF1211R; BF1211WR

DYNAMIC CHARACTERISTICS

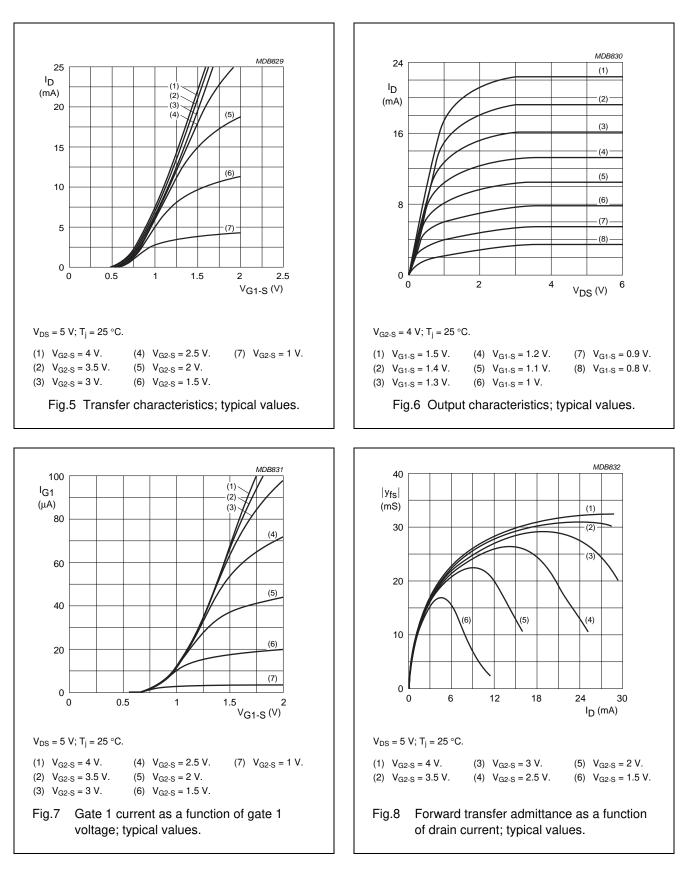
Common source; $T_{amb} = 25 \text{ °C}$; $V_{G2-S} = 4 \text{ V}$; $V_{DS} = 5 \text{ V}$; $I_D = 15 \text{ mA}$; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
y _{fs}	forward transfer admittance	pulsed; T _j = 25 °C	25	30	40	mS
C _{ig1-ss}	input capacitance at gate 1	f = 1 MHz	_	2.1	2.6	pF
C _{ig2-ss}	input capacitance at gate 2	f = 1 MHz	-	1.1	-	pF
C _{oss}	output capacitance	f = 1 MHz	-	0.9	-	pF
C _{rss}	reverse transfer capacitance	f = 1 MHz	-	15	30	fF
F	noise figure	f = 11 MHz; G_S = 20 mS; B_S = 0	-	3.5	-	dB
		$f = 400 \text{ MHz}; Y_S = Y_S (opt)$	-	0.9	1.6	dB
		$f = 800 \text{ MHz}; Y_S = Y_{S (opt)}$	-	1.3	2	dB
G _{tr}	power gain	$ f = 200 \text{ MHz}; G_S = 2 \text{ mS}; B_S = B_{S \text{ (opt)}}; G_L = 0.5 \text{ mS}; B_L = B_{L \text{ (opt)}} $	-	34	_	dB
		$ f = 400 \text{ MHz}; \text{G}_{\text{S}} = 2 \text{ mS}; \text{B}_{\text{S}} = \text{B}_{\text{S (opt)}}; \\ \text{G}_{\text{L}} = 1 \text{ mS}; \text{B}_{\text{L}} = \text{B}_{\text{L (opt)}} $	-	29	-	dB
		$ f = 800 \text{ MHz}; \text{G}_{\text{S}} = 3.3 \text{ mS}; \text{B}_{\text{S}} = \text{B}_{\text{S} \text{ (opt)}}; \\ \text{G}_{\text{L}} = 1 \text{ mS}; \text{B}_{\text{L}} = \text{B}_{\text{L} \text{ (opt)}} $	-	24	-	dB
X _{mod}	cross-modulation	input level for k = 1%; f _w = 50 MHz; f _{unw} = 60 MHz; note 1				
		at 0 dB AGC	90	-	-	$dB\mu V$
		at 10 dB AGC	-	92	-	$dB\mu V$
		at 40 dB AGC	100	105	-	$dB\mu V$

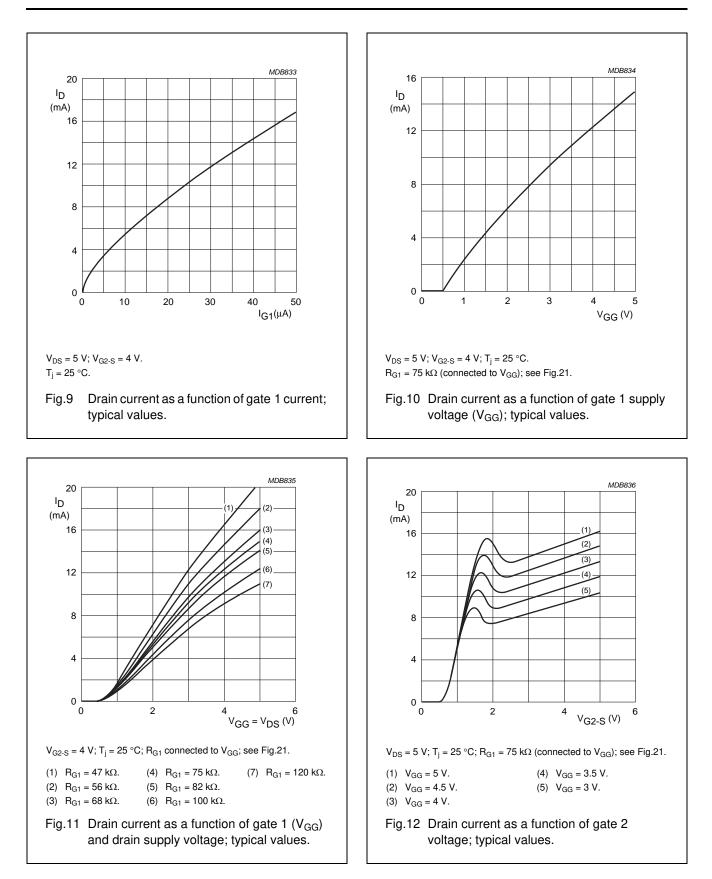
Note

1. Measured in test circuit Fig.21.

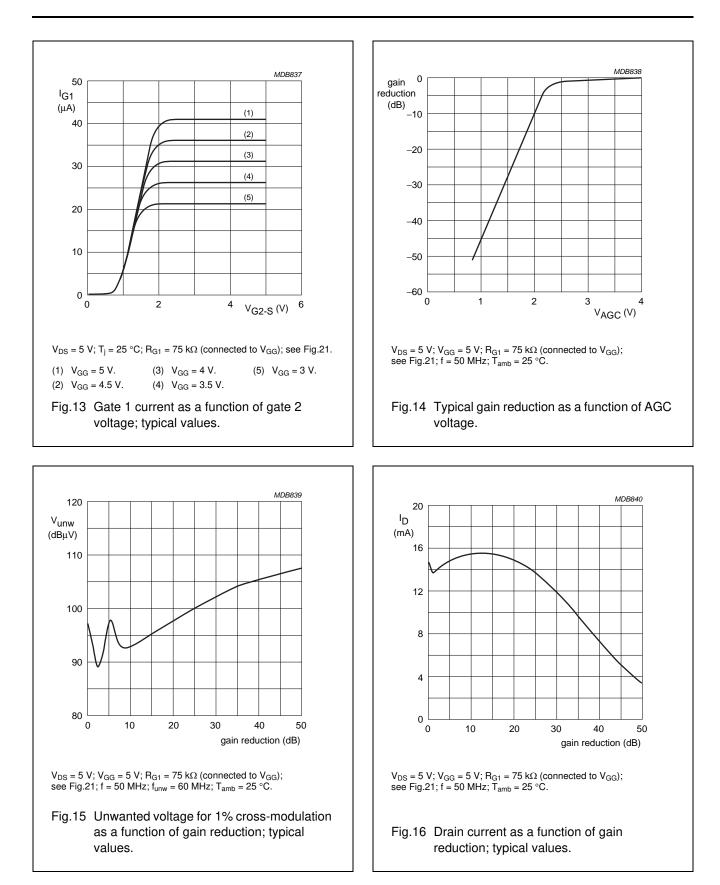
BF1211; BF1211R; BF1211WR



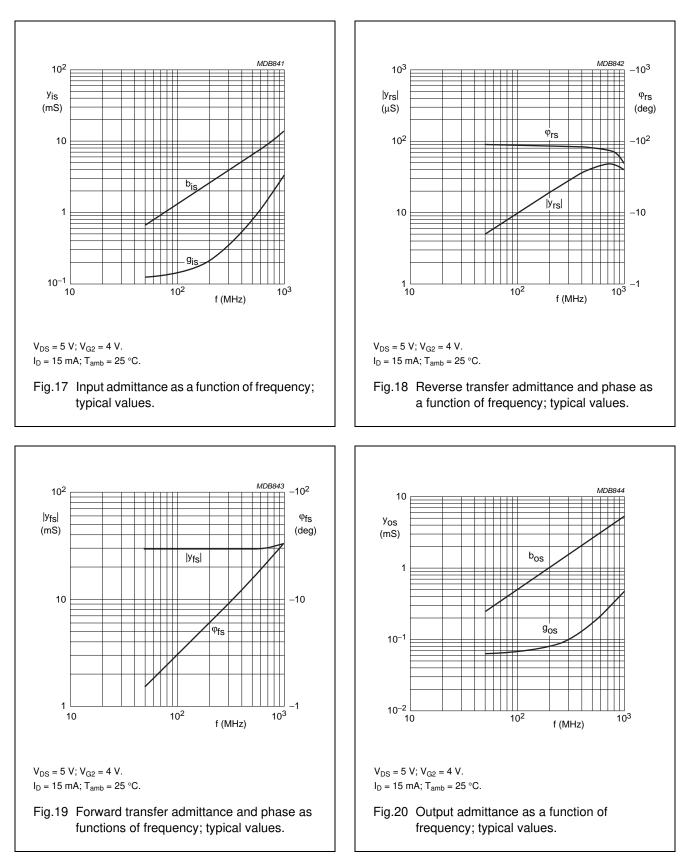




BF1211; BF1211R; BF1211WR



BF1211; BF1211R; BF1211WR



BF1211; BF1211R; BF1211WR

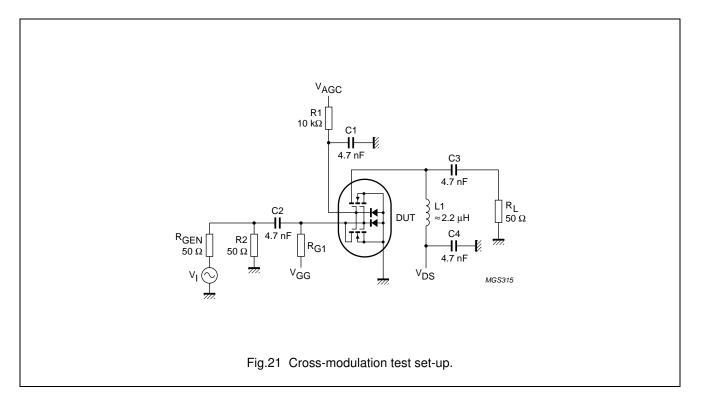


Table 1 Scattering parameters: V_{DS} = 5 V; V_{G2-S} = 4 V; I_D = 15 mA; T_{amb} = 25 °C

f	s ₁₁		S ₁₁ S ₂₁		s ₁₂		\$ ₂₂	
י (MHz)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)
50	0.987	-3.86	2.928	175.8	0.0005	89.3	0.993	-1.58
100	0.985	-7.73	2.921	171.6	0.0010	86.9	0.993	-3.14
200	0.979	-15.25	2.807	163.2	0.0015	91.1	0.993	-6.31
300	0.965	-22.84	2.846	155.0	0.0028	77.4	0.988	-9.41
400	0.949	-30.15	2.784	146.7	0.0034	74.0	0.985	-12.48
500	0.929	-30.25	2.704	138.9	0.0037	71.4	0.981	-15.54
600	0.904	-44.24	2.639	130.9	0.0040	69.6	0.976	-18.59
700	0.876	-51.16	2.558	123.0	0.0039	69.0	0.971	-21.65
800	0.846	-58.16	2.486	115.1	0.0037	70.0	0.965	-24.27
900	0.816	-65.15	2.402	107.2	0.0032	74.5	0.960	-27.79
1000	0.791	-72.22	2.315	99.9	0.0028	87.1	0.956	-30.94

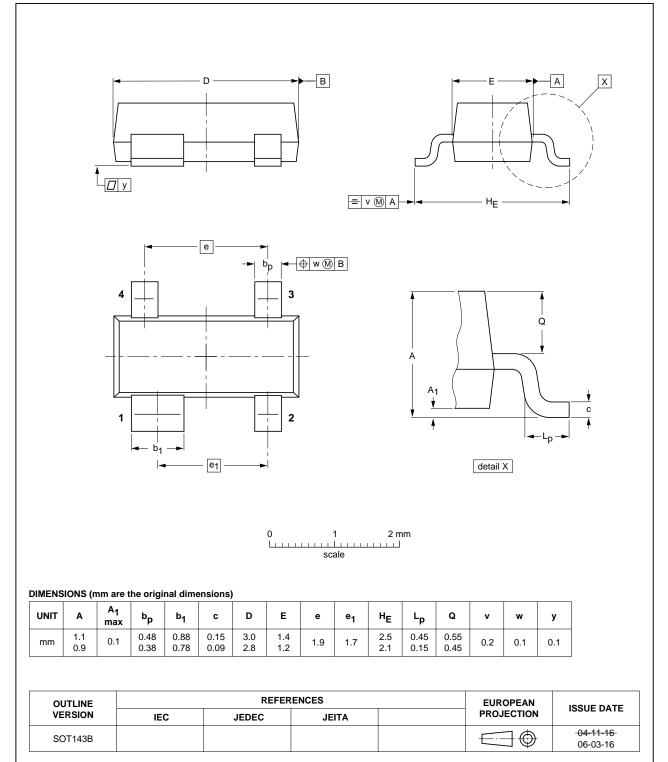
Table 2	Noise data:	$V_{DS} = 5 V;$	$V_{G2-S} = 4$	V; I _D =	15 mA; ⁻	Γ _{amb} = 25 °C
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f	F _{min}	Гс	ppt	R _n
(MHz)	(dB)	(ratio)	(deg)	(Ω)
400	0.9	0.693	16.75	29.85
800	1.3	0.707	37.33	29.90

BF1211; BF1211R; BF1211WR

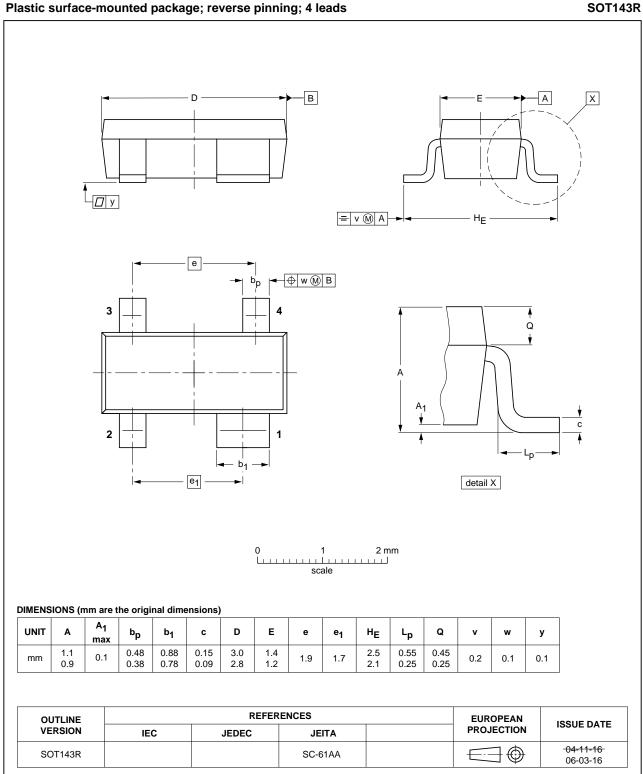
PACKAGE OUTLINES





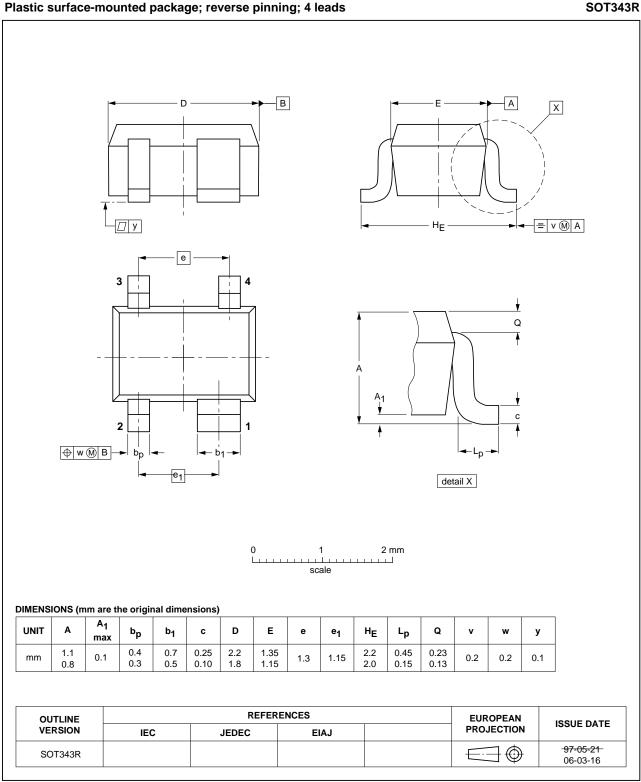
SOT143B

BF1211; BF1211R; BF1211WR



Plastic surface-mounted package; reverse pinning; 4 leads

BF1211; BF1211R; BF1211WR



Plastic surface-mounted package; reverse pinning; 4 leads

BF1211; BF1211R; BF1211WR

DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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BF1211; BF1211R; BF1211WR

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Contact information

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